

Laboratory on Mobile Robotics and Intelligent Systems LABORIUS





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Robust Sound Source Localization Using a Microphone Array on a Mobile Robot

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Sound Source Localization

- Determining where the sources of sounds are
 - Humans
 - Two ears
 - Head transfer function (acoustic shadow, reflections of sound by the ridges of the ear)
 - Robots
 - Two microphones (phase difference only)
 - Locate sounds over a planar area, without distinguishing the front from the back or high precision if the sound source is in the same axis
 - Eight microphones
 - Compensate for high level of complexity of the hearing sense
 - Filter out noise by discriminating multiple sound sources

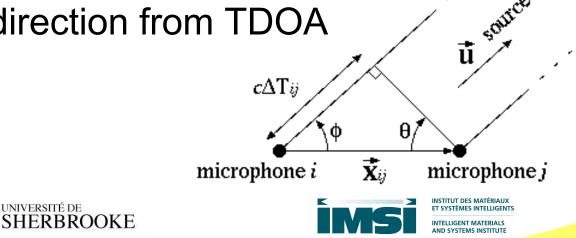






Approach Overview

- Sounds arrive at microphones with different delays (depending on distance)
 - Hypothesis: Punctual sound source, far field
- Extract Time Delay of Arrival (TDOA) between different microphones
- Compute direction from TDOA





- Delay found as peak in cross-correlation $R_{ij}(au) = \sum_{n=0}^{N-1} x_i[n] x_j[n- au]$
- Performed in frequency domain (faster)

$$R_{ij}(\tau) \approx \sum_{k=0}^{N-1} X_i(k) X_j(k)^* e^{i2\pi k\tau/N}$$





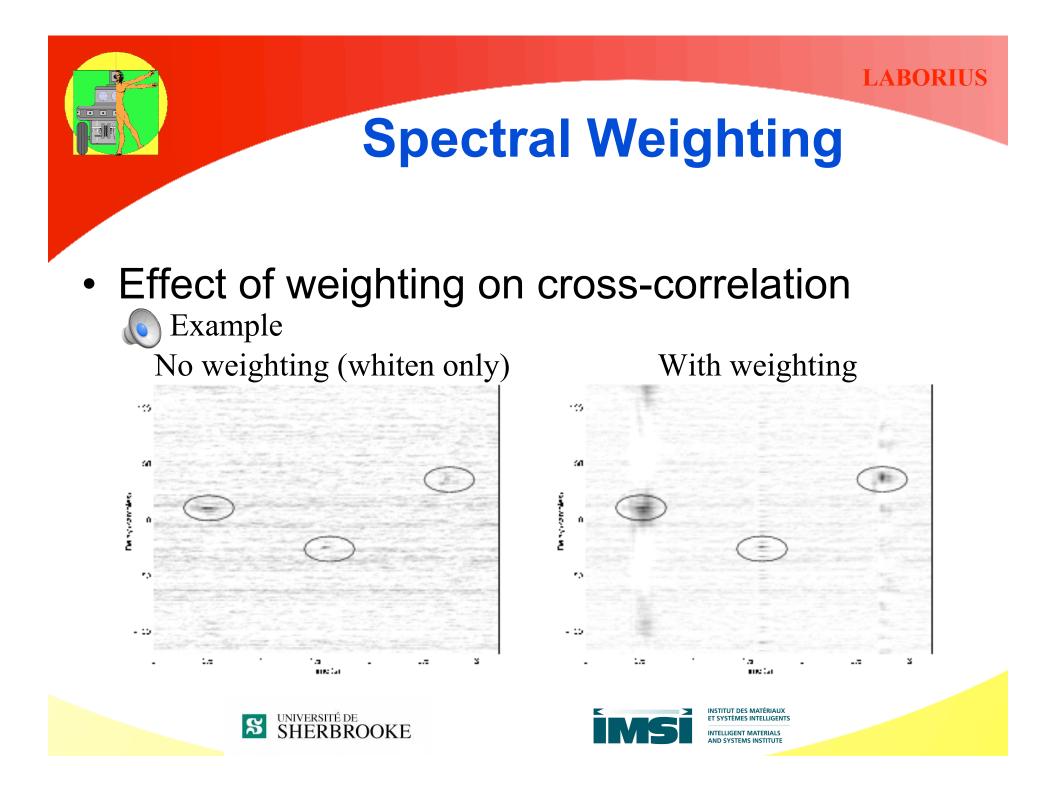


Enhanced Cross-Correlation

- Whitened cross-correlation
 - Cross-correlation on low-pass signal generates wide peaks in frequency: must narrow the wide maxima caused by the correlations within the received signals
 - Normalize spectrum (only phase information is preserved)
- Spectral weighting
 - Whitening gives less weight for frequencies dominated by noise: must give more weight to frequencies with high power









• For each microphone pair:

$$\Delta T_{ij} = \operatorname{argmax} R_{ij} (\tau)$$

$$\tau$$

• Extract *M* peaks (*M*=8) for each pair To make sure the source is detected





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Peak Coherence Search

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- N(N-1)/2 microphone pairs, N-1 deg. of freedom
- Dependent TDOAs satisfy:

$$\Delta T_{ij} = \Delta T_{1j} - \Delta T_{1i}$$

$$\Delta T_{23} = \Delta T_{13} - \Delta T_{12}$$

$$T_3 - T_2 = (T_3 - T_1) - (T_2 - T_1)$$

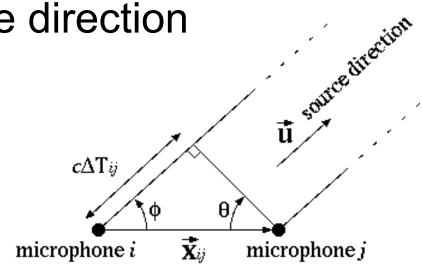
- Source detected if most constraints are met
- Depth-first search with pruning
- If more than one solution, only keep best







Once peaks are located, use them to compute direction



$$\vec{\mathbf{u}}\cdot\vec{\mathbf{x}}_{ij}=c\Delta T_{ij}$$





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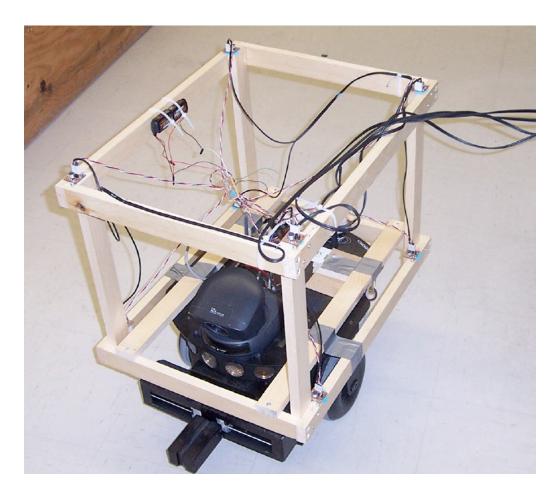
- $\begin{bmatrix} (x_2 x_1) & (y_2 y_1) & (z_2 z_1) \\ (x_3 x_1) & (y_2 y_1) & (z_3 z_1) \\ \vdots & \vdots & \vdots \\ (x_N x_1) & (y_N y_1) & (z_N z_1) \end{bmatrix} \begin{bmatrix} u \\ v \\ w \end{bmatrix} = \begin{bmatrix} c\Delta T_{12} \\ c\Delta T_{13} \\ \vdots \\ c\Delta T_{1N} \end{bmatrix}$
- Over-constrained (least square solution)
- Pseudo-inverse of matrix is constant and precomputed







Experimental Setup





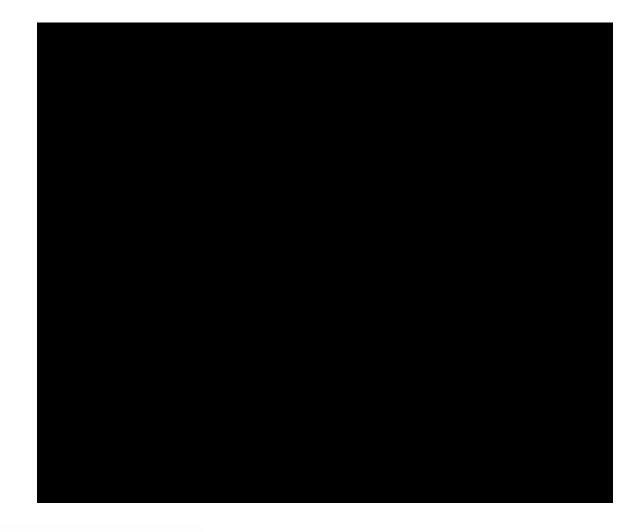


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Experiments







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Results

Distance, Elevation	Mean Ang. Error
3 m, -7°	1.7°
3 m, 8°	3°
1.5 m, -13°	3.1°
0.9 m, 24°	3.3°

- Error caused by reverberation, near-field effects, measurement precision, source size
- Accuracy shows no dependencies on angle (unlike binaural localization)







Pictures taken of detected sources







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- Sound source localization based on TDOA
 - Frequency-domain cross-correlation
 - Peak finding, coherence search
- Accuracy of ±3 degrees
- Works in noisy environments





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